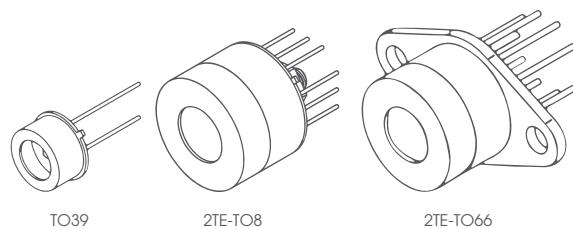


PVM-10.6 SERIES

HgCdTe room temperature and thermoelectrically cooled photovoltaic multi-junction infrared detectors



FEATURES

- Spectral range: 2.0 to 13.0 μm
- Back-side illuminated
- No minimum order quantity required
- Detector **PVM-10.6-1×1-TO39-NW-90** is a **Selected Line product**

RELATED PRODUCTS

- **LabM-I-10.6** detection module (p. 107)
- **UM-I-10.6** detection module (p. 113)
- **microM-10.6** detection module (p. 110)
- **PVIA-10.6-1×1-TO39-NW-36**
RoHS-compliant detector (p. 22)
- **PVIA-4TE-10.6-1×1-TO8-wZnSeAR-36**
RoHS-compliant detector (p. 22)

APPLICATIONS

- Gas detection, monitoring and analysis: SO_2 , NH_3 , SF_6
- CBRN threats detection
- CO_2 laser measurements: power monitoring and control, beam profiling and positioning, calibration
- Free-space optical communication
- FTIR spectroscopy
- Medical bacteria identification
- Dentistry
- Glucose sensing

SERIES DESCRIPTION

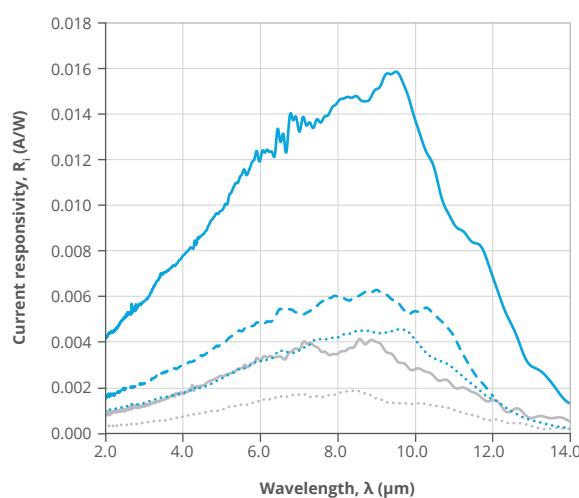
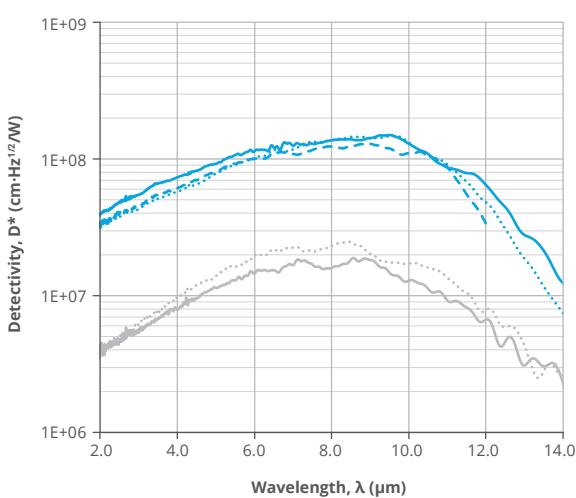
Detector symbol	Cooling (p. 191)	Temperature sensor (p. 192)	Active area, A, mm×mm	Optical immersion	Package	Acceptance angle, Φ , deg.	Window (p. 193)
PVM-10.6-1×1-TO39-NW-90	no	n/a	1×1		TO39 (3 pins)	~90	no
PVM-10.6-2×2-TO39-NW-90			2×2				
PVM-2TE-10.6-1×1-TO8-wZnSeAR-70			1×1		TO8		
PVM-2TE-10.6-1×1-TO66-wZnSeAR-70			1×1		TO66		
PVM-2TE-10.6-2×2-TO8-wZnSeAR-70	2TE $T_{\text{chip}}=230\text{K}$	thermistor	2×2	no	TO8	~70	wZnSeAR (3 deg. zinc selenide, anti-reflection coating)
PVM-2TE-10.6-2×2-TO66-wZnSeAR-70			2×2		TO66		
PVM-2TE-10.6-3×3-TO8-wZnSeAR-70			3×3		TO8		
PVM-2TE-10.6-3×3-TO66-wZnSeAR-70			3×3		TO66		

SPECIFICATION ($T_{\text{amb}} = 293 \text{ K}$, $V_b = 0 \text{ V}$)

Detector symbol	Cut-on wavelength (10%)	Peak wavelength	Specific wavelength	Cut-off wavelength (10%)	Detectivity		Current responsivity		Time constant		Dynamic resistance
	$\lambda_{\text{cut-on}}$	λ_{peak}	λ_{spec}	$\lambda_{\text{cut-off}}$	$D^*(\lambda_{\text{peak}}, 20\text{kHz})$	$D^*(\lambda_{\text{spec}}, 20\text{kHz})$	$R_i(\lambda_{\text{peak}})$	$R_i(\lambda_{\text{spec}})$	τ	R_d	
	μm	μm	μm	μm	$\text{cm}\cdot\text{Hz}^{1/2}/\text{W}$	$\text{cm}\cdot\text{Hz}^{1/2}/\text{W}$	A/W	A/W	ns	Ω	
Typ.	Typ.	Typ.	Typ.	Typ.	Min.	Typ.	Min.	Typ.	Typ.	Min.	Typ.
PVM-10.6-1x1-TO39-NW-90							0.004	0.002	0.0025		
PVM-10.6-2x2-TO39-NW-90	8.5±1.0			12.0	2.0×10^7	1.0×10^7	0.002	0.001	0.0015	1.5	30
PVM-2TE-10.6-1x1-TO8-wZnSeAR-70							0.015	0.01	0.012		
PVM-2TE-10.6-1x1-TO66-wZnSeAR-70	2.0		10.6								
PVM-2TE-10.6-2x2-TO8-wZnSeAR-70	9.0±1.0		13.0		1.5×10^8	1.0×10^8	0.007	0.005	0.006	4	90
PVM-2TE-10.6-2x2-TO66-wZnSeAR-70											
PVM-2TE-10.6-3x3-TO8-wZnSeAR-70							0.0045	0.03	0.04		
PVM-2TE-10.6-3x3-TO66-wZnSeAR-70											

SPECTRAL RESPONSE (Typ., $T_{\text{amb}} = 293 \text{ K}$)

— PVM-10.6-1x1-TO39-NW-90
 PVM-10.6-2x2-TO39-NW-90
 — PVM-2TE-10.6-1x1-TO8/TO66-wZnSeAR-70
 - - PVM-2TE-10.6-2x2-TO8/TO66-wZnSeAR-70
 PVM-2TE-10.6-3x3-TO8/TO66-wZnSeAR-70





MECHANICAL LAYOUT AND PINOUT

- TO39 (3 pins) package (without window)
 - Technical drawing (p. 197)
- 2TE-TO8 package
 - Technical drawing (p. 203)
- 2TE-TO66 package
 - Technical drawing (p. 205)

RECOMMENDED AMPLIFIERS

Detector symbol	Amplifier type
PVM-10.6-1x1-TO39-NW-90	SIP-TO39 series (p. 138)
PVM-10.6-2x2-TO39-NW-90	
PVM-2TE-10.6-1x1-TO8-wZnSeAR-70	AIP series (p. 126) PIP series (p. 129) MIP series (p. 132) SIP-TO8 series (p. 135)
PVM-2TE-10.6-2x2-TO8-wZnSeAR-70	
PVM-2TE-10.6-3x3-TO8-wZnSeAR-70	

ABSOLUTE MAXIMUM RATINGS

Parameter	Test conditions/remarks	Value	Unit
Ambient operating temperature, T_{amb}	Operation at $T_{amb} > 30^{\circ}\text{C}$ may increase the active element temperature and reduce the performance of the detector below specified parameters	-20 to 30	°C
Storage temperature, T_{stg}		-20 to 50	°C
Soldering temperature	Within 5 s or less	≤ 300	°C
Storage humidity	No dew condensation	10 to 90	%
Maximum incident optical power density	Continuous wave (CW) or single pulses >1 μs duration	100	W/cm²
	Single pulses <1 μs duration	1	MW/cm²
Maximum bias voltage, $V_{b\max}$	No bias voltage needed	-	-
Maximum TEC voltage, $V_{TEC\max}$	2TE	1.3	V
Maximum TEC current, $I_{TEC\max}$	2TE	1.2	A

Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. Constant or repeated exposure to absolute maximum rating conditions may affect the quality and reliability of the device.